

<b>Notice of References Cited</b>	Application/Control No. 10/500,486		Applicant(s)/Patent Under Reexamination IRIKUCHI ET AL.	
	Examiner DANIEL TEKLE		Art Unit 2481	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0092021	07-2002	Yap et al.	725/55
*	B	US-6,405,372	06-2002	Kim et al.	725/50
*	C	US-2002/0150382	10-2002	Sasaki et al.	386/68
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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#### FOREIGN PATENT DOCUMENTS

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	N					
	O					
	P					
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#### NON-PATENT DOCUMENTS

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